

Silicon Carbide Power MOSFET E-Series Automotive N-Channel Enhancement Mode

#### **Features**

- 3rd generation SiC MOSFET technology
- Optimized package with separate driver source pin
- 8mm of creepage distance between drain and source
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q<sub>rr</sub>)
- Halogen free, RoHS compliant
- Automotive Qualified (AEC-Q101) and PPAP Capable

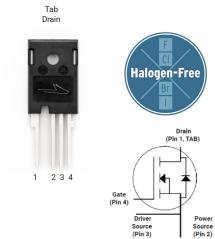
### **Benefits**

- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

### **Applications**

- **Motor Control**
- **EV Battery Chargers**
- High Voltage DC/DC Converters

# **Package**





	Source Source (Pin 3) (Pin 2)	
Part Number	Package	Marking
E3M0160120K	TO-247-4L	E3M0160120K

# Maximum Ratings (T<sub>c</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Value	Unit	Note	
$V_{DSmax}$	Drain - Source Voltage		1200	V	
$V_{GSmax}$	Gate - Source Voltage		-8/+19	٧	Note: 1
_			17.9	A	Fig. 19
I <sub>D</sub>	Continuous Drain Current, V <sub>GS</sub> = 15 V	T <sub>C</sub> = 100°C	13.5		Note: 2
I <sub>D(pulse)</sub>	Pulsed Drain Current, Pulse width t <sub>P</sub> limited by T <sub>jmax</sub>	34	А	Fig. 22	
$P_{\scriptscriptstyle D}$	Power Dissipation, T <sub>c</sub> =25°C, T <sub>J</sub> = 175 °C	103	W	Fig. 20 Note: 2	
$T_{J}$ , $T_{stg}$	Operating Junction and Storage Temperature		-55 to +175	°C	
$T_L$	Solder Temperature, 1.6mm (0.063") from case for 10s			°C	
$M_{d}$	Mounting Torque , M3 or 6-32 screw			Nm lbf-in	

Note (1): Recommended turn off / turn on gate voltage V<sub>GS</sub> - 4V...0V / +15V

Note (2): Verified by design

# **Electrical Characteristics** ( $T_c = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	1200			٧	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 100 μA	
	Coto Through ald Valence	1.8	2.8	3.6	٧	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 2.33 mA	Fig. 11
$V_{\text{GS(th)}}$	Gate Threshold Voltage		2.2		V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 2.33 mA, T <sub>J</sub> = 175°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current		1	50	μΑ	V <sub>DS</sub> = 1200 V, V <sub>GS</sub> = 0 V	
$I_{GSS}$	Gate-Source Leakage Current		10	250	nA	$V_{GS} = 15 \text{ V, } V_{DS} = 0 \text{ V}$	
R <sub>DS(on)</sub>	Drain-Source On-State Resistance		159	208	mΩ	V <sub>GS</sub> = 15 V, I <sub>D</sub> = 8.5 A	Fig. 4,
**DS(on)	Brain Source on State Resistance		280		11152	V <sub>GS</sub> = 15 V, I <sub>D</sub> = 8.5 A, T <sub>J</sub> = 175°C	5, 6
<b>g</b> fs	Transconductance		4.9		s	V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 8.5 A	Fig. 7
915	Transconductance	$\sqcup$	4.6			V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 8.5 A, T <sub>J</sub> = 175°C	
$C_{iss}$	Input Capacitance		730				
$C_{\text{oss}}$	Output Capacitance		31		pF	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 0V to 1000 V	Fig. 17, 18
C <sub>rss</sub>	Reverse Transfer Capacitance	Ħ	2			F = 1 MHz	
			17	+		Vac = 25 mV	Fig. 16
E <sub>oss</sub>	Coss Stored Energy	$\vdash$		+	μJ		Fig. 16 Note: 3
$C_{\text{o(er)}}$	Effective Output Capacitance (Energy Related)		36		pF	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 0 800V	
$C_{o(tr)}$	Effective Output Capacitance (Time Related)		55		pF		
E <sub>on</sub>	Turn-On Switching Energy (External Diode)		81			$V_{DS}$ = 800 V, $V_{GS}$ = -4 V/15 V, $I_D$ = 8.5 A,	Fig. 26, 28
E <sub>OFF</sub>	Turn Off Switching Energy (External Diode)		16		μJ	$R_{G(ext)}$ = 2.5 $\Omega$ , L= 404 $\mu$ H, T <sub>J</sub> = 175°C FWD = External SiC DIODE	
E <sub>on</sub>	Turn-On Switching Energy (Body Diode FWD)		134			$V_{DS}$ = 800 V, $V_{GS}$ = -4 V/15 V, $I_{D}$ = 8.5 A, $R_{G(ext)}$ = 2.5 $\Omega$ , L= 404 $\mu$ H, $T_{J}$ = 175°C	
E <sub>off</sub>	Turn-Off Switching Energy (Body Diode FWD)		15		μJ	FWD = Internal Body Diode	
t <sub>d(on)</sub>	Turn-On Delay Time		8				Fig. 27, 28
t <sub>r</sub>	Rise Time		9		ns	$V_{DD} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$ $I_D = 8.5 \text{ A}, R_{G(ext)} = 2.5 \Omega,$ $Timing relative to V_{DS}$ $Inductive load$	
$t_{\text{d(off)}}$	Turn-Off Delay Time		13				
t <sub>f</sub>	Fall Time		12			maddive load	
$R_{G(int)}$	Internal Gate Resistance		6.5		Ω	f = 1 MHz, V <sub>AC</sub> = 25 mV	
$Q_{gs}$	Gate to Source Charge		10			V <sub>DS</sub> = 800 V, V <sub>GS</sub> = -4 V/15 V	Fig. 12
$Q_{gd}$	Gate to Drain Charge		12		nC	I <sub>D</sub> = 8.5 A	
Qg	Total Gate Charge		32			Per IEC60747-8-4 pg 21	

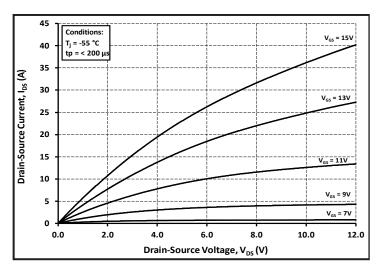
Note (3):  $C_{o(er)}$ , a lumped capacitance that gives same stored energy as Coss while Vds is rising from 0 to 800V  $C_{o(tr)}$ , a lumped capacitance that gives same charging time as Coss while Vds is rising from 0 to 800V

# **Reverse Diode Characteristics** ( $T_c = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
V	Diada Farruard Valtaga	4.8		٧	$V_{GS}$ = -4 V, $I_{SD}$ = 4.25 A, $T_{J}$ = 25 °C	Fig. 8,
$V_{SD}$	Diode Forward Voltage	4.2		٧	$V_{GS} = -4 \text{ V, I}_{SD} = 4.25 \text{ A, T}_{J} = 175 ^{\circ}\text{C}$	Fig. 8, 9, 10
Is	Continuous Diode Forward Current		17	Α	V <sub>GS</sub> = -4 V, T <sub>C</sub> = 25°C	
I <sub>S, pulse</sub>	Diode pulse Current		34	Α	$V_{GS}$ = -4 V, pulse width $t_P$ limited by $T_{jmax}$	
t <sub>rr</sub>	Reverse Recover time	9		ns	V <sub>GS</sub> = -4 V, I <sub>SD</sub> = 8.5 A, V <sub>R</sub> = 800 V dif/dt = 6080 A/μs, T <sub>J</sub> = 175 °C	
Q <sub>rr</sub>	Reverse Recovery Charge	169		nC		
I <sub>rrm</sub>	Peak Reverse Recovery Current	27		Α		
t <sub>rr</sub>	Reverse Recover time	23		ns		
Q <sub>rr</sub>	Reverse Recovery Charge	147		nC	$V_{GS} = -4 \text{ V, } I_{SD} = 8.5 \text{ A, } V_{R} = 800 \text{ V}$ dif/dt = 1850 A/ $\mu$ s, $T_{J} = 175 ^{\circ}\text{C}$	
I <sub>rrm</sub>	Peak Reverse Recovery Current	11		Α		

### **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	1.13	1.45	°C/W		Fig. 21



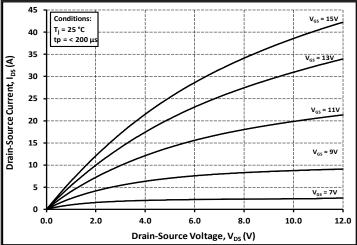
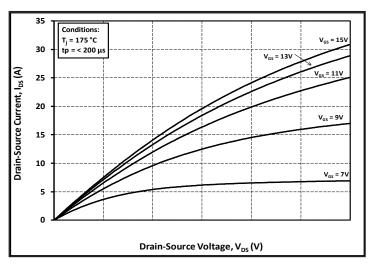


Figure 1. Output Characteristics T<sub>J</sub> = -55 °C

Figure 2. Output Characteristics  $T_J = 25$  °C



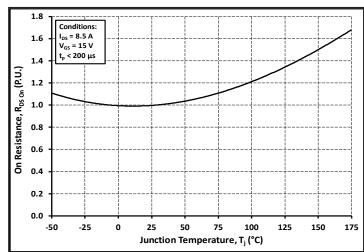
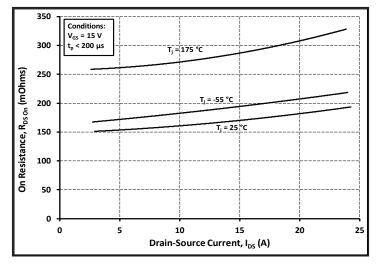


Figure 3. Output Characteristics T<sub>J</sub> = 175 °C

Figure 4. Normalized On-Resistance vs. Temperature



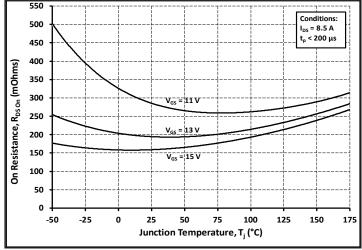


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

Figure 6. On-Resistance vs. Temperature For Various Gate Voltage

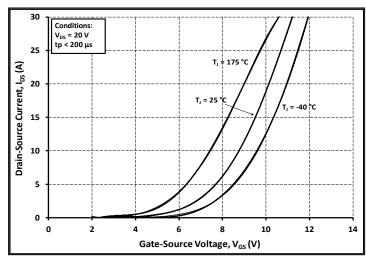


Figure 7. Transfer Characteristic for Various Junction Temperatures

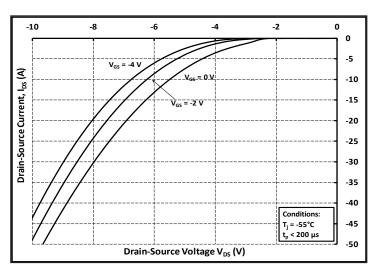


Figure 8. Body Diode Characteristic at -55 °C

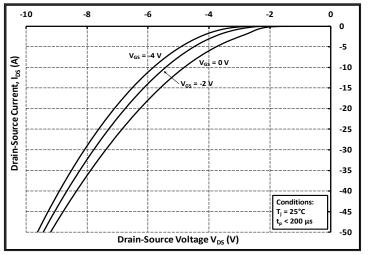


Figure 9. Body Diode Characteristic at 25 °C

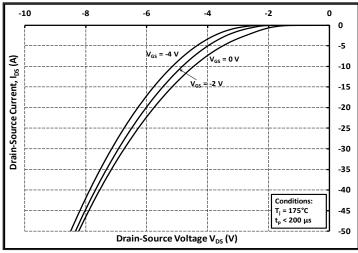


Figure 10. Body Diode Characteristic at 175 °C

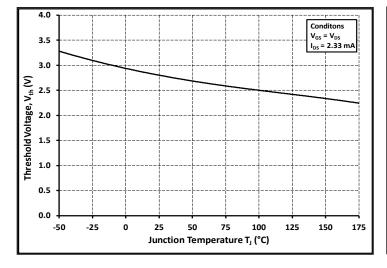


Figure 11. Threshold Voltage vs. Temperature

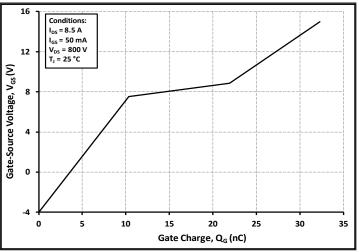


Figure 12. Gate Charge Characteristics

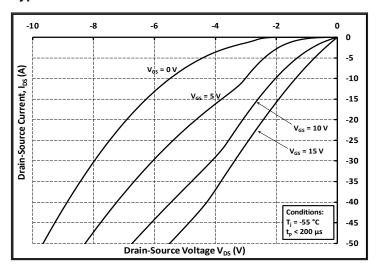


Figure 13. 3rd Quadrant Characteristic at -55 °C

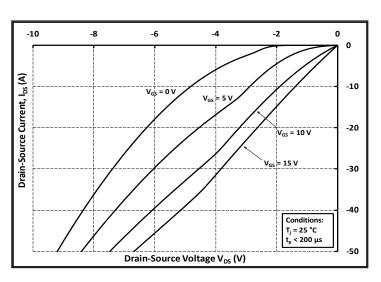


Figure 14. 3rd Quadrant Characteristic at 25 °C

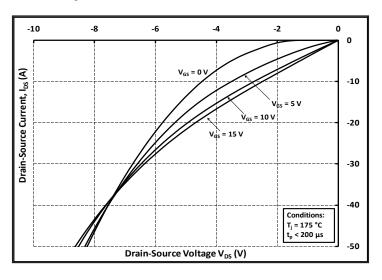


Figure 15. 3rd Quadrant Characteristic at 175 °C

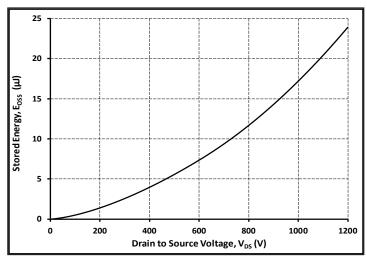


Figure 16. Output Capacitor Stored Energy

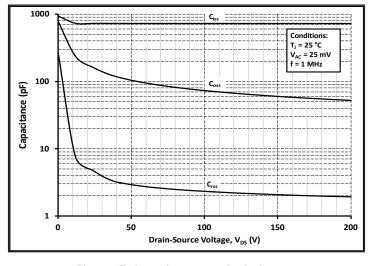


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

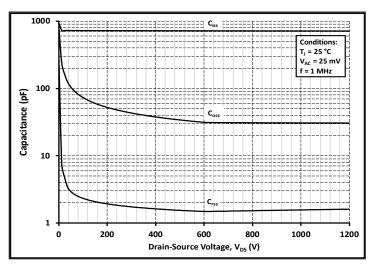


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1200V)

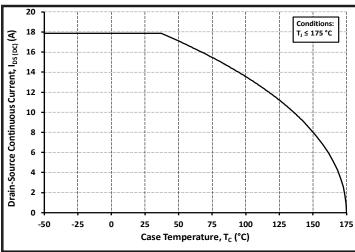
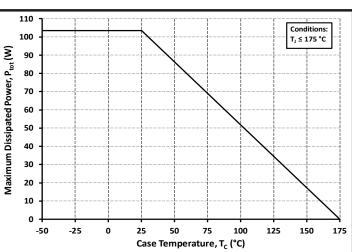


Figure 19. Continuous Drain Current Derating vs. Figure 20. Maximum Power Dissipation Derating vs. Case Temperature Case Temperature



Junction To Case Impedance, Z<sub>thJC</sub> (°C/W) 10E-3 1E-6 10E-6 100E-6 1E-3 Time, t<sub>p</sub> (s)

Figure 21. Transient Thermal Impedance (Junction - Case)

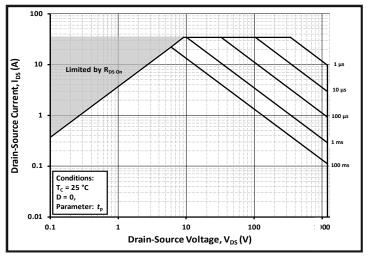


Figure 22. Safe Operating Area

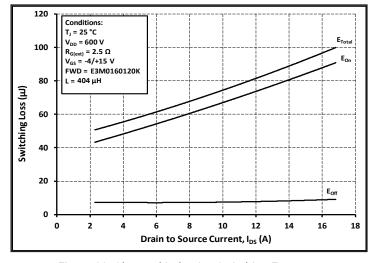


Figure 23. Clamped Inductive Switching Energy vs. Drain Current  $(V_{DD} = 600V)$ 

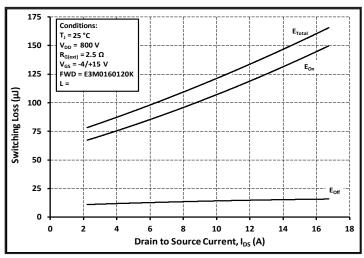


Figure 24. Clamped Inductive Switching Energy vs. Drain Current (V<sub>DD</sub> = 800V)

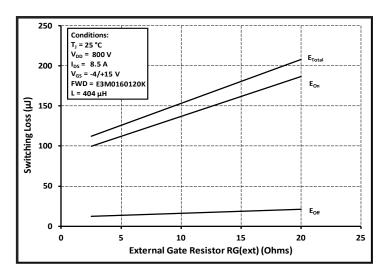


Figure 25. Clamped Inductive Switching Energy vs.  $R_{\text{G(ext)}}$ 

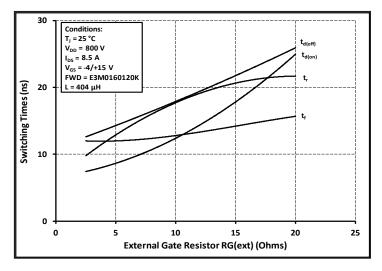


Figure 27. Switching Times vs.  $R_{G(ext)}$ 

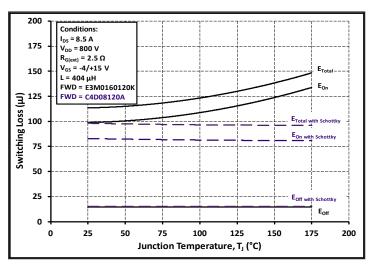


Figure 26. Clamped Inductive Switching Energy vs.
Temperature

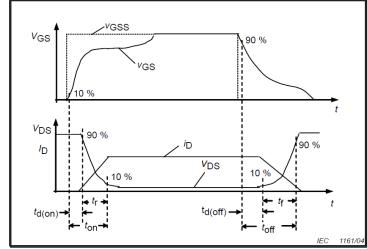


Figure 28. Switching Times Definition

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## **Test Circuit Schematic**

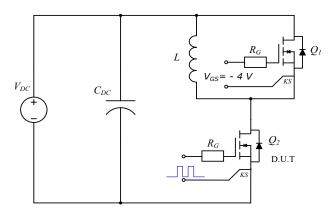
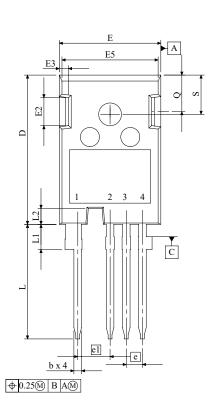
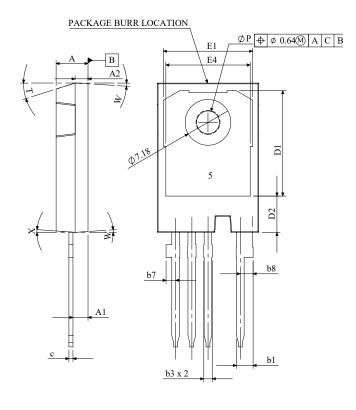


Figure 29. Clamped Inductive Switching Waveform Test Circuit

### **Package Dimensions**





SYMBOL	MIN (mm)	MAX (mm)		
A	4.83	5.21		
A1	2.23	2.54		
A2	1.91	2.16		
b	1.07	1.33		
bl	2.39	2.94		
b3	1.07	1.60		
b7	1.30	1.70		
b8	1.80	2.20		
С	0.55	0.68		
D	23.30	23.63		
D1	16.25	17.65		
D2	5.55	5.95		
Е	15.75	16.13		
E1	13.1	14.15		
E2	3.68	5.10		
E3	1.00	1.90		
E4	12.38	13.43		
E5	14.65	15.05		
e1	5.08 BSC			
L	17.31	17.82		
L1	3.97	4.37		
L2	2.35	2.65		
ØΡ	3.51	3.65		
Q	5.49 6.00			
S	6.04 6.30			
T	17.5° REF.			
W	3.5 ° REF.			
X	4° REF.			

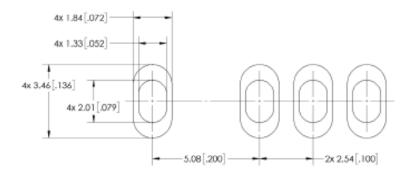
DRAIN		
SOURCE		
DRIVER SOURCE		
GATE		
DRAIN		

#### NOTE:

- $\begin{array}{ll} {\rm 1.} & {\rm ALL~METAL~SURFACES~ARE~TIN~PLATED~(MATTE),} \\ {\rm EXCEPT~AREA~OF~CUT.} \end{array}$
- 2. DIMENSIONING & TOLERANCING CONFORM TO ASME Y14.5M-1994.
- 3. ALL DIMENSIONS ARE LISTED IN MILLIMETERS. ANGLES ARE IN DEGREES.
- 4. BURR OR MOLD FLASH SIZE (0.5 mm) IS NOT INCLUDED IN THE DIMENSIONS

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# **Recommended Solder Pad Layout**



## **Revision history**

Document Version	Date of release	Descriptiion of changes
1.0	June-2023	Initial datasheet
2.0	October-2023	Corrected value of Rdson max
3	January - 2025	Legal Disclaimer Updated

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